

Minutes from OpenPICs WP 3 meeting 06-11-2017

Present: Weiming, Rob, Rui, Huub, Meint, Kevin, Victor, Xaveer, Saeed

Time: 14:00-15:00

Discussion/action points

Nr.	Description	Responsible
1.	DBR Laser test Results shown of DBR laser on SP19 with good performance values. Saeed mentions measurements from EFFECT indicating 50 cm^{-1} coupling. Mentions possible butt-joint reflections in measurement.	
2.	Generic BB Test Cell Meint suggests new structure for electrical loss measurement involving DBRs.	
3	Data Structure Model Discussion on data model: Ronald will present example in January to illustrate the concept and its application for project partners.	Ronald, Jan 2018
4	Description Files Chip, measurement and equipment description files can contain information for automated measurement of chips. Xaveer will show in 4 weeks a demonstration of how those are structured.	Xaveer, 4 th Dec 2017

Next meeting is 20th November, 2017, 14:00